

#### NCE N-Channel Enhancement Mode Power MOSFET

#### **Description**

The NCE0140I2 uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. It can be used in a wide variety of applications.

#### **General Features**

•  $V_{DS} = 100V, I_D = 40A$  $R_{DS(ON)} < 15mΩ @ V_{GS} = 10V$  (Typ:13mΩ)

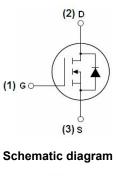
- Special process technology for high ESD capability
- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high E<sub>AS</sub>
- Excellent package for good heat dissipation

#### **Application**

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply

100% UIS TESTED!

100% ΔVds TESTED!





Marking and pin assignment



TO-251 top view

## **Package Marking and Ordering Information**

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
NCE0140I2	NCE0140I2	TO-251	-	-	-

#### Absolute Maximum Ratings (T<sub>C</sub>=25℃unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V <sub>DS</sub>	100	V
Gate-Source Voltage	V <sub>G</sub> s	±20	V
Drain Current-Continuous	I <sub>D</sub>	40	Α
Drain Current-Continuous(T <sub>C</sub> =100 °C)	I <sub>D</sub> (100°C)	28	А
Pulsed Drain Current	I <sub>DM</sub>	160	А
Maximum Power Dissipation	P <sub>D</sub>	140	W
Derating factor	-	0.94	W/℃
Single pulse avalanche energy (Note 5)	E <sub>AS</sub>	520	mJ
Operating Junction and Storage Temperature Range	$T_{J}, T_{STG}$	-55 To 175	$^{\circ}$



# http://www.ncepower.com

#### **Thermal Characteristic**

	Thermal Resistance, Junction-to-Case <sup>(Note 2)</sup>	Rejc	1.07	°C/W
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# Electrical Characteristics (T<sub>C</sub>=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics			•			
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =250µA	100	110	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =100V,V <sub>GS</sub> =0V	-	-	1	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V,V <sub>DS</sub> =0V	-	-	±100	nA
On Characteristics (Note 3)						
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =250μA	2	3	4	V
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =28A	-	13	15	mΩ
Forward Transconductance	<b>g</b> FS	V <sub>DS</sub> =25V,I <sub>D</sub> =28A	32	-	-	S
Dynamic Characteristics (Note4)			•			
Input Capacitance	C <sub>lss</sub>	V 00V/V 0V	-	3400	-	PF
Output Capacitance	Coss	V <sub>DS</sub> =30V,V <sub>GS</sub> =0V,	-	290	-	PF
Reverse Transfer Capacitance	Crss	F=1.0MHz	-	221	-	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	t <sub>d(on)</sub>		-	15	-	nS
Turn-on Rise Time	t <sub>r</sub>	VDD=30V,ID=2A,RL=15Ω,	-	11	-	nS
Turn-Off Delay Time	$t_{\sf d(off)}$	RG=2.5Ω,VGS=10V	-	52	-	nS
Turn-Off Fall Time	t <sub>f</sub>		-	13	-	nS
Total Gate Charge	Qg		-	94	-	nC
Gate-Source Charge	Q <sub>gs</sub>	ID=30A,VDD=30V,VGS=10V	-	16	-	nC
Gate-Drain Charge	$Q_{gd}$		-	24	-	nC
Drain-Source Diode Characteristics			•			
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =28A	-	0.85	1.2	V
Diode Forward Current (Note 2)	Is		-	-	40	Α
Reverse Recovery Time	t <sub>rr</sub>	TJ = 25°C, IF = 28A	-	33		nS
Reverse Recovery Charge	Qrr	di/dt = 100A/µs <sup>(Note3)</sup>	-	54		nC
Forward Turn-On Time	ton	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				
		I .				

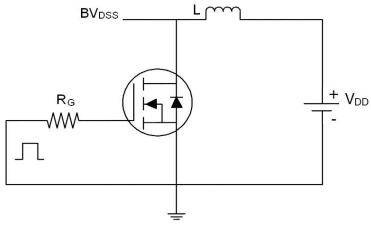
### Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- **2.** Surface Mounted on FR4 Board,  $t \le 10$  sec.
- **3.** Pulse Test: Pulse Width ≤  $300\mu$ s, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production
- **5.** EAS condition: Tj=25 $^{\circ}$ C,V<sub>DD</sub>=50V,V<sub>G</sub>=10V,L=0.5mH,Rg=25 $\Omega$

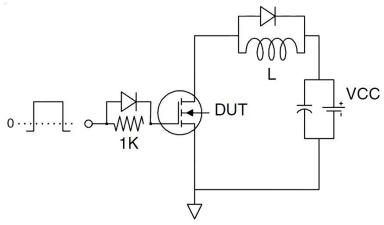


# **Test Circuit**

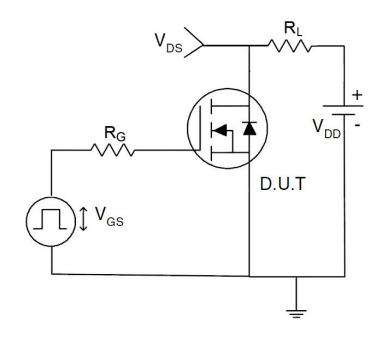
# 1) E<sub>AS</sub> test Circuit



# 2) Gate charge test Circuit

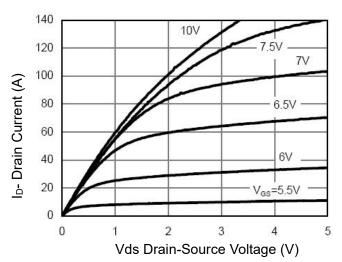


#### 3) Switch Time Test Circuit

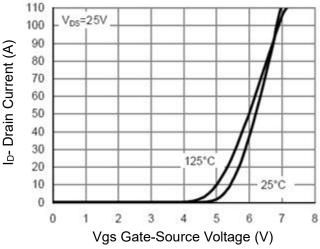




## **Typical Electrical and Thermal Characteristics (Curves)**



**Figure 1 Output Characteristics** 



**Figure 2 Transfer Characteristics** 

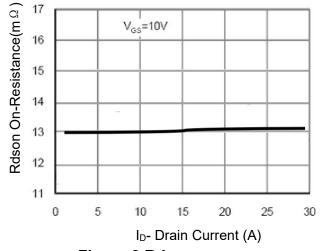


Figure 3 Rdson- Drain Current

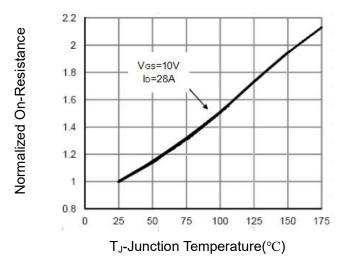
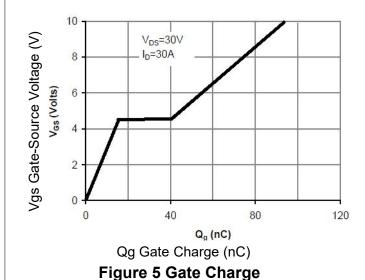


Figure 4 Rdson-JunctionTemperature



1.0E+02 W 1.0E+01 1.0E+00 1.0E-01 1.0E-02 1.0E-03 1.0E-04 0.0 0.2 0.4 0.6 0.8 1.0 1.2

Vsd Source-Drain Voltage (V)

Figure 6 Source- Drain Diode Forward



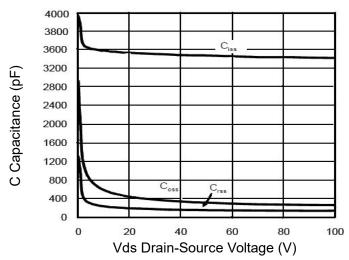
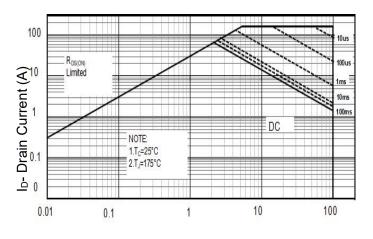


Figure 7 Capacitance vs Vds



Vds Drain-Source Voltage (V)

Figure 8 Safe Operation Area

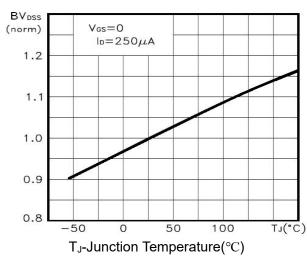


Figure 9 BV<sub>DSS</sub> vs Junction Temperature

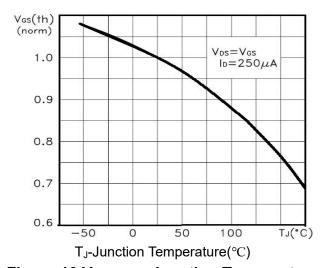
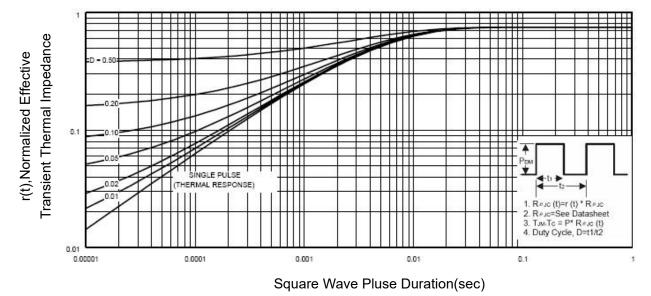


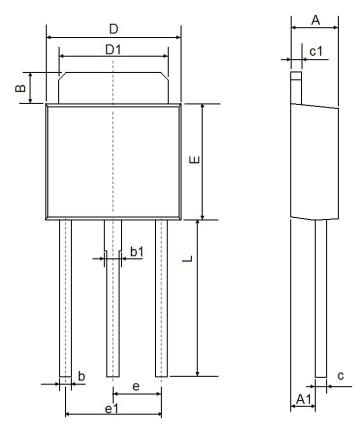
Figure 10 V<sub>GS(th)</sub> vs Junction Temperature



**Figure 11 Normalized Maximum Transient Thermal Impedance** 



# **TO-251(C) Package Information**



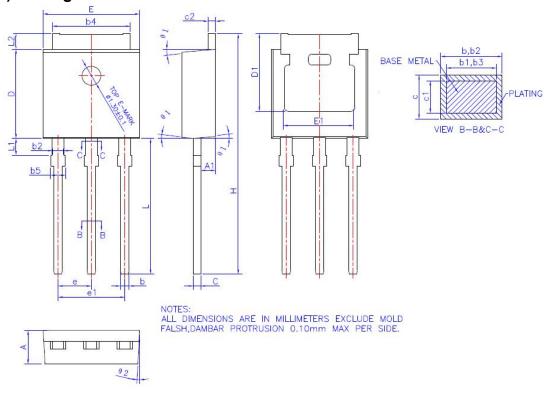
Commele ed	Dimensions	In Millimeters	Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
А	2.200	2.400	0.087	0.094	
A1	1.050	1.350	0.042	0.054	
В	1.350	1.650	0.053	0.065	
b	0.500	0.700	0.020	0.028	
b1	0.700	0.900	0.028	0.035	
С	0.430	0.580	0.017	0.023	
c1	0.430	0.580	0.017	0.023	
D	6.350	6.650	0.250	0.262	
D1	5.200	5.400	0.205	0.213	
E	5.400	5.700	0.213	0.224	
е	2.300 TYP		0.091 TYP		
e1	4.500	4.700	0.177	0.185	
L	7.500	7.900	0.295	0.311	

#### Notes

- 1. All dimensions are in millimeters.
- 2. Tolerance  $\pm 0.10$ mm (4 mil) unless otherwise specified
- $3. \ Package \ body \ sizes \ exclude \ mold \ flash \ and \ gate \ burrs. \ Mold \ flash \ at \ the \ non-lead \ sides \ should \ be \ less \ than \ 5 \ mils.$
- 4. Dimension L is measured in gauge plane.
- 5. Controlling dimension is millimeter, converted inch dimensions are not necessarily exact



# TO-251 (J) Package Information



# COMMON DIMENSIONS (UNITS OF MEASURE =MILLIMETER)

SYMBOL	MIN	NOM	MAX
Α	2.20	2.30	2.35
A1	0,90	1.01	1.10
b	0,56		0,69
b1	0.55	0.60	0.65
b2	0.77	10 <del>200</del>	0.90
b3	0.76	0.81	0.86
b4	5.23	5.33	5.43
b5	<del>-</del>	Sa <del>rtina</del>	1.05
С	0,46		0.59
c1	0.45	0.51	0.55
c2	0.46	19 <u>2244</u>	0.59
D	6.00	6.10	6,20
D1	5.20	94 <del>3000</del>	<del>-</del>
E	6.50	6.60	6.70
E1	4.60	4.83	5.00
е	2,24	2,29	2,34
e1	4.47	4.57	4.67
Н	16.18	16.48	16.78
L	9.00	9,30	9,60
L1	0.95	1,16	1,35
L2	0.90	1.08	1.25
θ1	3°	5°	7°
θ2	1°	3°	5°



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